



<b>Form 1449 (Modified)</b>  <b>Information Disclosure Statement By Applicant</b>  (Use Several Sheets if Necessary)	Atty Docket No. TRNDP015 Applicant: Liang Filing Date 10/09/03	Application No.: 10/683,584  Group 2131

#### U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
KN	A	2003/145228	07/31/03	Suuronen et al.			
	B						
	C						
	D						
	E						
	F						
	G						
	H						
	I						

#### Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
KN	J	03/014932	20.02.03	PCT				
	K							
	L							
	M							
	N							

#### Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
KN	O	Hameroff, "A holistic approach to enterprise security", Unisys World, 'Online! May 2003.
KN	P	White et al., "Anatomy of a Commercial-Grade Immune System", IBM Research White Paper, June 1999.
	Q	
Examiner /Khoi Nguyen/		Date Considered 12/26/2006

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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(Use Several Sheets if Necessary)	Filing Date October 9, 2003	Group 2131

#### U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
KN	A	5,623,600	4/22/97	Ji et al.			9/26/95
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	E						
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#### Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
KN	J	EP 1 335 559 A2	13.08.2003	European Patent Office			X	
	K							
	L							
	M							
	N							

#### Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	O	
	P	
	Q	
Examiner /Khoi Nguyen/		Date Considered 12/26/2006

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